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Space systems — Design qualification and acceptance tests of small spacecraft and units

*Systèmes spatiaux — Qualification de la conception et essais de
réception des petits véhicules spatiaux*



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ISO copyright office
Ch. de Blandonnet 8 • CP 401
CH-1214 Vernier, Geneva, Switzerland
Tel. +41 22 749 01 11
Fax +41 22 749 09 47
copyright@iso.org
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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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This document was prepared by Technical Committee ISO/TC 20, *Aircraft and space vehicles*, Subcommittee SC 14, *Space systems and operations*.

Introduction

There is an increasing demand for small/micro/nano/pico satellite development and utilization worldwide; yet, there is no clear and globally accepted definition of what is considered “small”, “micro”, “nano” or “pico” satellites. These satellites are often built with emphasis on low cost and fast delivery. They are characterized by extensive use of non-space-qualified commercial-off-the-shelf (COTS) units. For the sake of convenience, the term “small spacecraft” is used throughout this document as a generic term to refer to these satellites.

A small spacecraft is a satellite that utilizes non-traditional risk-taking development and management approaches to achieve low cost and fast delivery with a small number of team. To achieve these two points, low cost and fast delivery, satellite design relies on the use of non-space-qualified commercial-off-the-shelf (COTS) units, making satellite size inherently smaller. The design accepts a certain level of risk associated with the use of COTS.

A certain set of tests is necessary to ensure the mission success of small spacecraft. Applying the same test requirements and methods as those applied to traditional large/medium satellites, however, will nullify the low-cost and fast-delivery advantages possessed by small spacecraft.

This document is meant to improve the reliability of small spacecraft, especially those with commercial purpose, while maintaining the low-cost and fast-delivery nature of small spacecraft. This document intends to promote worldwide trade of small spacecraft products by providing a minimum level of assurance that a product made of non-space-qualified commercial-off-the-shelf parts and units can work in space. This document also aims to serve as a testing guideline for those who intend to enter satellite manufacturing through development of small spacecraft products.